



PRODUCT DATA SHEET



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Datasheet Resource

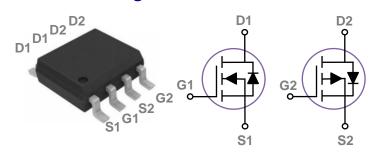
Please note: Please check the JINGAO Semiconductor website to verify the updated device numbers. The most current and up-to-date ordering information can be found at www.jg-semi.cn. Please email any questions regarding the system integration to JINGAO_questions@jgsemi.com.



General Description

These N+P dual Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

SOP8	Pin	Configuration



BVDSS	RDSON	ID
40V	32m $Ω$	6.7A
-40V	40m $Ω$	-7.2A

Features

- Fast switching
- Green Device Available
- Suit for 4.5V Gate Drive Applications

Applications

- DC Fan
- Motor Drive Applications
- Networking
- Half / Full Bridge Topology

Absolute Maximum Ratings Tc=25°C unless otherwise noted

Symbol	Parameter	Rati	ng	Units
V_{DS}	Drain-Source Voltage	40	-40	V
V _G S	Gate-Source Voltage	±20	±20	V
lp	Drain Current – Continuous (T _A =25°C)	6.7	-7.2	Α
ID	Drain Current – Continuous (T _A =70°C)	5.4	-5.7	А
I _{DM}	Drain Current – Pulsed ¹	26.8	-28.8	А
Po	Power Dissipation (T _A =25°C)	2		W
FU	Power Dissipation – Derate above 25°C	0.01	16	W/°C
T _{STG}	Storage Temperature Range	-55 to 150		℃
TJ	Operating Junction Temperature Range	-55 to	150	℃

Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Unit
RθJA	Thermal Resistance Junction to Ambient		62.5	°C/W



N-CH Electrical Characteristics (T_J=25 °C, unless otherwise noted) Off Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	40			V
△BV _{DSS} /△T _J	BV _{DSS} Temperature Coefficient	Reference to 25°C , I _D =1mA		0.04		V/°C
1		V _{DS} =40V , V _{GS} =0V , T _J =25°C			1	uA
IDSS	Drain-Source Leakage Current	V _{DS} =32V , V _{GS} =0V , T _J =125°C				uA
I _{GSS}	Gate-Source Leakage Current	V _{GS} =±20V , V _{DS} =0V			±100	nA

On Characteristics

R _{DS(ON)} Static Drain-Source On-Resistance	Statio Drain Source On Registance	V _{GS} =10V , I _D =5A		24	32	mΩ
	V _{GS} =4.5V , I _D =3A		32	45	mΩ	
V _{GS(th)}	Gate Threshold Voltage	-V _{GS} =V _{DS} , I _D =250uA	1.0	1.8	2.5	V
$\Delta V_{GS(th)}$	V _{GS(th)} Temperature Coefficient			-3		mV/°C
gfs	Forward Transconductance	$V_{DS}=10V$, $I_{D}=3A$		3.6		S

Dynamic and switching Characteristics

Q_g	Total Gate Charge ^{2,3}		 2.8	5.6	
Q_{gs}	Gate-Source Charge ^{2,3}	V_{DS} =20V , V_{GS} =4.5V , I_{D} =3A	 0.5	1	nC
Q_{gd}	Gate-Drain Charge ^{2,3}		 1.5	3	
T _{d(on)}	Turn-On Delay Time ^{2,3}		 3.2	6	
Tr	Rise Time ^{2, 3}	V_{DD} =20 V , V_{GS} =4.5 V , R_{G} =25 Ω	 8.6	16	no
$T_{d(off)}$	Turn-Off Delay Time ^{2,3}	I _D =1A	 18	36	ns
T_f	Fall Time ^{2, 3}		 6	12	
Ciss	Input Capacitance		 420	800	
Coss	Output Capacitance	V_{DS} =15V , V_{GS} =0V , F =1MHz	 65	120	pF
Crss	Reverse Transfer Capacitance		 40	80	

Drain-Source Diode Characteristics and Maximum Ratings

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current	V _G =V _D =0V , Force Current			6.7	Α
I _{SM}	Pulsed Source Current				13.4	Α
V_{SD}	Diode Forward Voltage	V _{GS} =0V , I _S =1A , T _J =25°C			1	V

Note:

- 1. Repetitive Rating : Pulsed width limited by maximum junction temperature.
- 2. The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%.
- 3. Essentially independent of operating temperature.



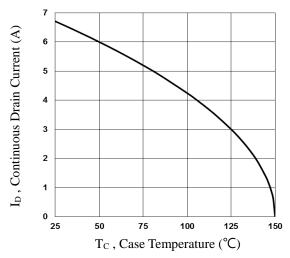


Fig.1 Continuous Drain Current vs. Tc

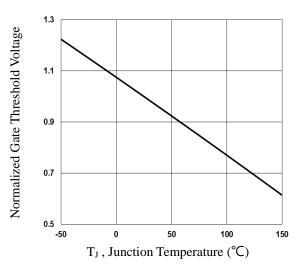


Fig.3 Normalized V_{th} vs. T_J

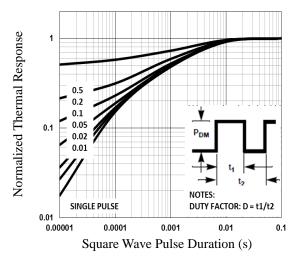


Fig.5 Normalized Transient Impedance

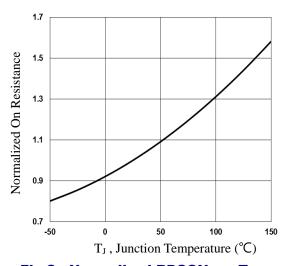


Fig.2 Normalized RDSON vs. T_J

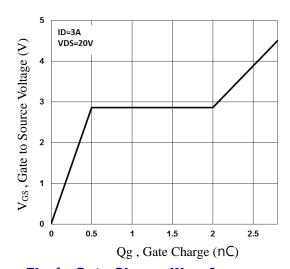


Fig.4 Gate Charge Waveform

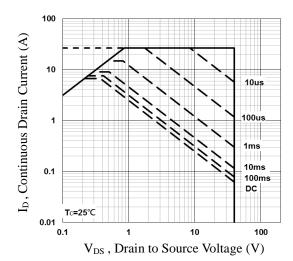


Fig.6 Maximum Safe Operation Area



P-CH Electrical Characteristics (T_J=25 °C, unless otherwise noted) Off Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D = - 250uA	- 40			V
$\triangle BV_{DSS}/\triangle T_{J}$	BV _{DSS} Temperature Coefficient	Reference to 25°C , I _D =-1mA		-0.04		V/°C
lana	Drain-Source Leakage Current	V _{DS} =-40V , V _{GS} =0V , T _J =25°C			-1	uA
IDSS		V _{DS} =-32V , V _{GS} =0V , T _J =125°C			-10	uA
I _{GSS}	Gate-Source Leakage Current	$V_{GS}=\pm20V$, $V_{DS}=0V$			±100	nA

On Characteristics

Proyen	R _{DS(ON)} Static Drain-Source On-Resistance	V _{GS} =-10V , I _D =-4A		32	40	mΩ
NDS(ON)		V _{GS} =-4.5V , I _D =-2A		45	60	mΩ
V _{GS(th)}	Gate Threshold Voltage	-V _{GS} =V _{DS} , I _D =-250uA	-1.0	-1.6	-2.5	V
$\triangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient			3		mV/°C
gfs	Forward Transconductance	V _{DS} =-10V , I _D =-3A		5		S

Dynamic and switching Characteristics

Qg	Total Gate Charge ^{5, 6}			8	16	
Q_gs	Gate-Source Charge ^{5,6}	V_{DS} =-20V , V_{GS} =-4.5V , I_{D} =-2A	-	2.1	4.2	nC
Q_gd	Gate-Drain Charge ^{5, 6}			3.6	7.2	
T _{d(on)}	Turn-On Delay Time ^{5,6}			20	40	
Tr	Rise Time ^{5,6}	V_{DD} =-20V , V_{GS} =-4.5V , R_{G} =25 Ω	-	12	24	ns
$T_{d(off)}$	Turn-Off Delay Time ^{5,6}	I _D =-1A		46	80	115
Tf	Fall Time ^{5,6}			6	12	
C _{iss}	Input Capacitance			1050	1600	
Coss	Output Capacitance	V _{DS} =-15V , V _{GS} =0V , F=1MHz		110	160	pF
C_{rss}	Reverse Transfer Capacitance			80	120	

Drain-Source Diode Characteristics and Maximum Ratings

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current	V _G =V _D =0V , Force Current			-7.2	Α
lsм	Pulsed Source Current				-14.4	Α
V _{SD}	Diode Forward Voltage	V _{GS} =0V , I _S =-1A , T _J =25°C			-1	V

Note:

- 4. Repetitive Rating : Pulsed width limited by maximum junction temperature.
- 5. The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%.
- 6. Essentially independent of operating temperature.



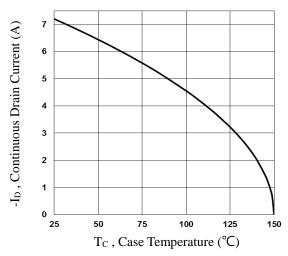


Fig.7 Continuous Drain Current vs. Tc

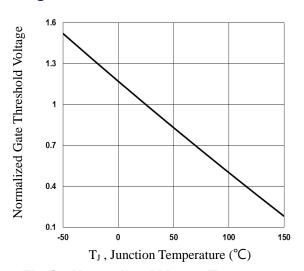


Fig.9 Normalized Vth vs. T_J

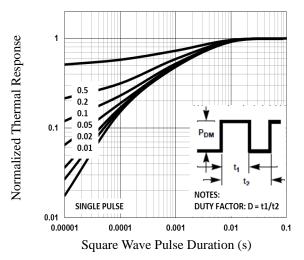


Fig.11 Normalized Transient Impedance

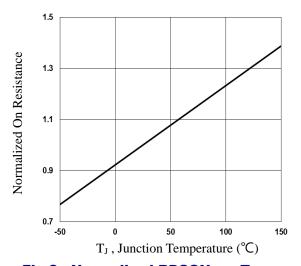


Fig.8 Normalized RDSON vs. T_J

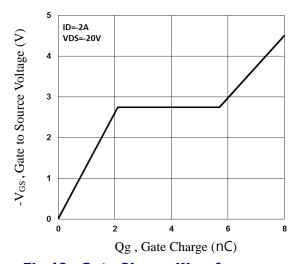


Fig.10 Gate Charge Waveform

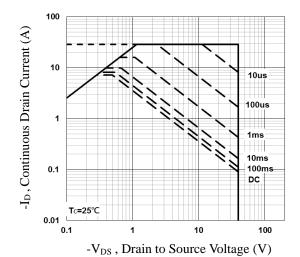
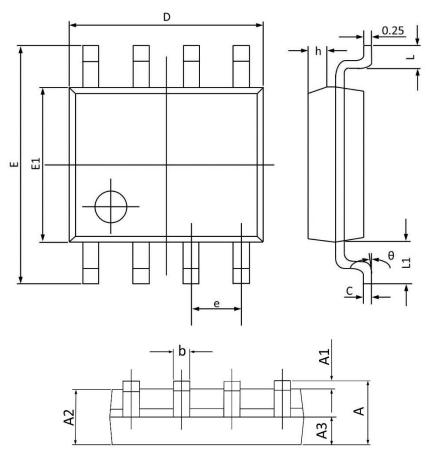


Fig.12 Maximum Safe Operation Area



SOP8 PACKAGE INFORMATION



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
Α	1.350	1.800	0.053	0.069
A1	0.050	0.250	0.002	0.010
A2	1.250	1.650	0.049	0.065
А3	0.500	0.700	0.020	0.028
b	0.300	0.510	0.012	0.020
С	0.150	0.260	0.006	0.010
D	4.700	5.100	0.185	0.201
E	5.800	6.200	0.228	0.244
E1	3.700	4.100	0.146	0.161
е	1.270(BSC)		0.050(BSC)	
h	0.250	0.500	0.010	0.020
L	0.400	1.000	0.016	0.039
L1	1.050(BSC)		0.041(BSC)	
θ	0°	8°	0 °	8°



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